Description of polarisation dependence of two-photon absorption in silicon avalanche photodiodes


A simple formula is obtained that very accurately describes the level of two-photon absorption (TPA) generated by elliptically polarised light in silicon avalanche photodiodes (Si-APDs). The dichroism parameter necessary to describe the polarisation dependence of TPA in Si-APDs at room temperature is determined to be +0.372 in the region of 1550 nm.

Introduction: Two-photon absorption (TPA) in semiconductors has recently generated strong interest as a means of performing a variety of optical pulse characterisation techniques. The autocorrelation of pulses as short as 6 fs has been reported using a TPA photodetector [1]. Optical sampling and characterisation in telecommunication networks have also been demonstrated using TPA detectors [2, 3]. Previously, TPA based detection has been predominantly carried out using silicon avalanche photodiodes (Si-APDs). Owing to the fluctuation of signal polarisation in telecommunications networks it is essential to understand the polarisation dependence of TPA in Si-APDs very accurately so that these fluctuations can be properly accounted for in the pulse characterisation schemes. In a recent study, we have determined the polarisation dependence of TPA in a GaAs microcavity detector [4, 5].

In this Letter, we describe experiments to measure the polarisation dependence of TPA generated photocurrent (I_{TPA}) in Si-APDs. We give a simple formula which very accurately describes this dependence at room temperature and show that it is not simply proportional to the optical field (E) of the incident optical signal to the fourth power I_{TPA} \propto (|E(t)|^2)^2, where (|\cdot|) and \langle \cdot \rangle are the time average and magnitude of E(t), respectively [6]. Also reported for the first time in Si-APDs at room temperature is the value of the dichroism parameter (\delta) which is found to be +0.372 in the region of 1550 nm.

Theory: The degenerate TPA generated photocurrent in Si can be described as I_{TPA} = C|B(t)|^2, where B is the polarisation-dependent TPA absorption coefficient in Si, C is a polarisation-independent constant, Pt(t) is the power of incident optical signal which can be described as \sqrt{\xi}_{\text{pol}}P(t) where \xi_{\text{pol}} is the complex-valued Jones vector describing the signals polarisation, a, b, and c are unit vectors which define the local co-ordinate system. The signal polarisation and its propagation direction have been defined based on this local co-ordinate system. The polarisation dependence of degenerate TPA has previously been described in [7] as being dependent on three parameters. These are, \chi_{\text{c}}(\omega), \sigma, and \delta, where x, y, and z are the unit vectors along the [100], [010], and [001] crystallographic directions of Si, respectively. x is a fourth rank tensor that describes the third-order susceptibility of Si, where \kappa'_{\text{pol}} is used as a shorthand representation of Im[\chi_{\text{c}}(\omega)], \alpha, \omega, and \omega_0, etc. are the anisotropy parameter, where \sigma = [\chi_{\text{c}}(\omega) - 2h_{\text{c}}/\chi_{\text{pol}}] and \delta is the dichroism parameter, where \delta = [\chi_{\text{c}}(\omega) + 2h_{\text{c}}/\chi_{\text{pol}}]. The value of \sigma in Si-APDs has previously been reported at 1550 nm as 0 at room temperature [6, 8]. The value for \delta at a wavelength of 1550 nm at room temperature has not previously been reported in Si.

The polarisation dependence of the TPA coefficient in Si has previously been described as [5, 7]:

\[ \beta = \frac{\omega}{2n_0c^2|E_0|}k'_{\text{pol}}\left(1 - \frac{\sigma - \delta}{2}\right)\left(|\xi_{\text{pol}}|^2 + |\xi'_{\text{pol}}|^2\right) + \alpha t^2|t|^4 + |t'|^4, \]

where \omega, n, c, \alpha, etc. are optical frequency, refractive index, speed of light and permittivity of free space, respectively. Based on (1) the TPA current generated in Si can be expressed in terms of \sigma and \delta:

\[ I_{TPA} = C'(S_0(t)^2 - S_1(t)^2 - \sigma S_2(t^2)) \]

where \sigma' = C \frac{\omega}{2n_0c^2|E_0|}k'_{\text{pol}}, which is a polarisation-independent constant and S_{0,2,3} are three Stokes parameters, where S_0(t) = P(t), S_1(t) = (\xi_1^2 t + \xi_2^2 t')P(t), and S_2(t) = -i(\xi_1^2 t - \xi_2^2 t')P(t). Using this definition, the TPA photocurrent generated by a polarised signal in Si-APDs can be easily calculated once \sigma and \delta are known.

Experiment: TPA measurements were carried out using a commercial (Perkin Elmer) Si-APD. A 1 nm band-limited ASE source (BL-ASE) was generated using an erbium-doped fibre amplifier (EDFA) with no injected optical signal. The ASE output passed through a 1 nm filter with its peak transmission centred on 1544 nm. The BL-ASE passed through a polarisation controller which consists of an input polariser and quarter- and half-wave plates. Using the polarisation controller the polarisation of the input signal onto the detector can be set. The input signal was collimated and passed through a free space optical chopper before being focused onto the Si-APD using a 10x microscope objective (numerical aperture = 0.25). It was ensured that the focused beam was normally incident on the detector. The Si-APD was biased at 180 V, which generates sufficient current amplification so as to allow the TPA photocurrent signal to be monitored using a lock-in amplifier.

The TPA dependence on linear polarisation was investigated first. The incident power on the detector was kept constant at 1.94 mW for all polarisation measurements, which is high enough to ensure that TPA dominated the absorption over any single photon absorption process. The polarisation dependence of the TPA photocurrent was recorded as linear polarisation and was rotated around the equator of the Poincaré sphere, the results are shown in Fig. 1. In this case, S_3 is zero, which as seen from (2), leads to the TPA dependence on linear polarisation orientation being independent of \delta. Fitting the linear polarisation dependence of the Si-APD allows \sigma to be determined. The TPA photocurrent is found to be independent of linear polarisation orientation corresponding to \sigma = 0, in line with previous reports [6, 8].

The polarisation dependence of the TPA photocurrent is then recorded as the input polarisation was rotated from circular to linear to circular along seven different longitudinal axes of the Poincaré sphere: C (0, 90, 180); TPA dependence on ellipticity fitted using equation given in this Letter (Circular theory) and approximation in [6] (Salem).

The polarisation dependence of the TPA photocurrent is then recorded as the input polarisation was rotated from circular to linear to circular along seven different longitudinal axes of the Poincaré sphere passing the equator at orientation angles varying from 0° to 180° in steps of 30°, see Fig. 1 (where three representative curves are shown). From the curves it can be seen that the TPA photocurrent generated by a circularly-polarised optical signal is approximately 0.63 of that produced by a linearly polarised signal. The polarisation dependence is fitted using (2) with \sigma = 0 and \delta as the fitting parameter. The TPA data is normalised by the maximum TPA photocurrent value and then all TPA values are subtracted from 1 before being divided by S_4. TPA values associated with S_4 values less than 0.33 are excluded from the analysis owing to their proximity to the singularity associated with dividing by S_4 = 0 and the sensitivity of the fitting to small fluctuations associated with dividing by small S_4 values. The fitting results in a mean value for \delta of +0.372 with a standard deviation of 0.001 associated with fitting the 168 remaining data points. This allows the polarisation dependence of TPA in Si-APDs around 1550 nm at room temperature to be expressed as:

\[ I_{TPA} = C'(S_0(t)^2 - 0.372 S_4(t^2)) \]
It can also be seen in Fig. 1 that the polarisation dependence of TPA calculated using the approximation in [6] does not result in as good an agreement with the ratio of TPA generated by linearly- compared with circularly-polarised signals.

Conclusion: A simple equation is given to characterise the polarisation dependence of TPA in Si-APDs. This equation is shown to correctly take into account the influence of the dichroism parameter ($\delta$). A value for $\delta$ of +0.372 around 1550 nm has been measured at room temperature and is shown to fit experimental data very well.

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